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	L #	Hits	EAST Search Text	DBs	Time Stamp	Type
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2	L2	3	("5578331" "5844802" "5696686").PN.	USPAT	2004/08/19 17:05	BRS
3	L3	1	("5461570").PN.	USPAT	2004/08/19 17:06	BRS
4	L4	7	5749205.URPN.	USPAT	2004/08/19 17:05	BRS
5	L6	11	5687541.URPN.	USPAT	2004/08/19 17:05	BRS
6	L8	6	5844802.URPN.	USPAT	2004/08/19 17:48	BRS
7	L9	6	5696686.URPN.	USPAT	2004/08/19 17:50	BRS
8	L1 0	7	5675962.URPN.	USPAT	2004/08/19 17:52	BRS
9	L1 1	13	5649410.URPN.	USPAT	2004/08/19 17:53	BRS
10	L1 2	20	5578331.URPN.	USPAT	2004/08/19 17:55	BRS
11	L1 3	17	5555504.URPN.	USPAT	2004/08/19 17:57	BRS
12	L1 4	9	5528878.URPN.	USPAT	2004/08/19 18:02	BRS
13	L1 5	2	("6609041").PN.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/19 18:04	IS&R

09/925 389

	1	Document ID	Source	Issue Date	Title	Current OR	Inventor	2	3
1	<input checked="" type="checkbox"/>	US 5749205 A	USPAT	19980512	Automated apparatus and method for consolidating products for packaging	53/542	Edwards, Russell James et al.	<input type="checkbox"/>	<input checked="" type="checkbox"/>
2	<input type="checkbox"/>	US 5687541 A	USPAT	19971118	Automated apparatus and method for preparing contact lenses for inspection and packaging	53/54	Martin, Wallace Anthony et al.	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
3	<input checked="" type="checkbox"/>	US 6609041 B1	USPAT	20030819	Method and system for SKU tracking and changeover	700/115	Sanka, Ravi S. et al.	<input type="checkbox"/>	<input checked="" type="checkbox"/>
4	<input type="checkbox"/>	US 6341726 B1	USPAT	20020129	Apparatus for inspecting elements on transport device	235/462.13	Castanedo, Agustin Del Rio et al.	<input checked="" type="checkbox"/>	<input type="checkbox"/>
5	<input type="checkbox"/>	US 6246062 B1	USPAT	20010612	Missing lens detection system and method	250/461.1	Ross, III, Denwood F. et al.	<input checked="" type="checkbox"/>	<input type="checkbox"/>
6	<input type="checkbox"/>	US 5891371 A	USPAT	19990406	Interactive control method for packaging control of time sensitive products	264/2.1	Lepper, John Mark et al.	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
7	<input checked="" type="checkbox"/>	US 5844802 A	USPAT	19981201	Production line tracking and quality control system	700/115	Lepper, John Mark et al.	<input type="checkbox"/>	<input checked="" type="checkbox"/>
8	<input type="checkbox"/>	US 5675962 A	USPAT	19971014	Automated apparatus and method for preparing contact lenses for inspection and packaging	53/445	Martin, Wallace Anthony et al.	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
9	<input type="checkbox"/>	US 5649410 A	USPAT	19970722	Post-hydration method and apparatus for transporting, inspecting and packaging contact lenses	53/474	Martin, Wallace Anthony et al.	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
10	<input type="checkbox"/>	US 5578331 A	USPAT	19961126	Automated apparatus for preparing contact lenses for inspection and packaging	425/445	Martin, Wallace A. et al.	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
11	<input type="checkbox"/>	US 5555504 A	USPAT	19960910	Production line tracking and quality control system	700/115	Lepper, John M. et al.	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
12	<input checked="" type="checkbox"/>	US 6622102 B2	USPAT	20030916	Method and system for tracking manufacturing data for integrated circuit parts	702/84	Skidmore, Beth	<input checked="" type="checkbox"/>	<input type="checkbox"/>
13	<input type="checkbox"/>	US 6522939 B1	USPAT	20030218	Computer system for quality control correlation	700/116	Strauch, Robert D. et al.	<input checked="" type="checkbox"/>	<input type="checkbox"/>
14	<input checked="" type="checkbox"/>	US 6446017 B1	USPAT	20020903	Method and system for tracking manufacturing data for integrated circuit parts	702/81	Skidmore, Beth	<input checked="" type="checkbox"/>	<input type="checkbox"/>
15	<input checked="" type="checkbox"/>	US 6092001 A	USPAT	20000718	Control method and apparatus of line and line system	700/116	Mizuno, Yoshihiro et al.	<input checked="" type="checkbox"/>	<input type="checkbox"/>
16	<input checked="" type="checkbox"/>	US 5528878 A	USPAT	19960625	Automated apparatus and method for consolidating products for packaging	53/54	Edwards, Russell J. et al.	<input type="checkbox"/>	<input checked="" type="checkbox"/>

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2	L2	1744	(53/52-54,493-500).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 09:54	IS&R
3	L3	699	(702/81-84).CCLS.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 09:54	IS&R
4	L4	154	((700/95,108-110,112-116,213-215,217-219,223-226,228-230).CCLS.) AND (((53/52-54,493-500).CCLS.) OR ((702/81-84).CCLS.))	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 09:54	BRS
5	L5	0	((700/95,108-110,112-116,213-215,217-219,223-226,228-230).CCLS.) AND ((53/52-54,493-500).CCLS.) AND ((702/81-84).CCLS.)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 09:54	BRS
6	L6	137	((700/95,108-110,112-116,213-215,217-219,223-226,228-230).CCLS.) AND (((53/52-54,493-500).CCLS.) OR ((702/81-84).CCLS.))) AND (quality OR inspect\$3 OR monitor\$3 OR track\$3)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 12:40	BRS
7	L7	8	("5164905" "5434790" "5761064" "5841677" "5862055" "6131052" "6161054" "6202037").PN.	USPAT	2004/08/20 09:59	BRS
8	L8	16	5434790.URPN.	USPAT	2004/08/20 10:45	BRS
9	L9	2	6035243.URPN.	USPAT	2004/08/20 11:31	BRS
10	L10	18	("5208762" "5504332" "5522512" "5533606" "5660305" "5671592" "5713485" "5713487" "5720154" "5751581" "5761877" "5765606" "5768140" "5771657" "5842118" "5850187" "6317648"	USPAT	2004/08/20 11:38	BRS
11	L11	2	6182049.URPN.	USPAT	2004/08/20 12:21	BRS
12	L12	21	("3725867" "4381447" "4580226" "4691830" "4829445" "4888692" "5006992" "5050088" "5191313" "5233533" "5311438" "5327437" "5386360" "5396432" "5442561" "5493501" "5612886" "5841677" "6021359" "6026365"	USPAT	2004/08/20 12:22	BRS
13	L13	17	L4 NOT L6	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 12:32	BRS

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16	L1 6	9	6067507.URPN.	USPAT	2004/08/20 12:39	BRS
17	L1 7	1839	(L1 OR L2 OR L3) AND (quality OR inspect\$3 OR monitor\$3 OR track\$3 OR reject\$3).ti,ab,clm.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 13:04	BRS
18	L2 0	161	L17 AND ((assembly OR production OR fabrication OR transfer) ADJ line OR factory).ti,ab,clm.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 12:44	BRS
19	L2 1	141	L20 NOT (L6 OR L7 OR L8 OR L9 OR L10 OR L11 OR L12 OR L13 OR L14 OR L15 OR L16)	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 12:45	BRS
20	L2 2	43	5399531.URPN.	USPAT	2004/08/20 12:53	BRS
21	L2 3	20	(L1 OR L2 OR L3) AND (contact ADJ lens\$2).ti,ab,clm.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2004/08/20 13:05	BRS

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1	<input type="checkbox"/>	US 6604012 B1	USPAT	20030805	Lots dispatching method for variably arranging processing equipment and/or processing conditions in a succeeding process according to the results of a preceding process and apparatus for the same	700/121	Cho, Dae-Sik et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
2	<input type="checkbox"/>	US 5862055 A	USPAT	19990119	Automatic defect classification individual defect predicate value	700/121	Chen, Ming Chun et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
3	<input type="checkbox"/>	US 5841677 A	USPAT	19981124	Method and apparatus for dispatching lots in a factory	702/176	Yang, Terry H. et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
4	<input type="checkbox"/>	US 5434790 A	USPAT	19950718	Versatile production system and pallet used for the system	700/110	Saka, Nobuo et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
5	<input type="checkbox"/>	US 6035243 A	USPAT	20000307	System for handling defects produced during the automated assembly of palletized elements	700/110	Galuga, Marta A. et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
6	<input type="checkbox"/>	US 6522945 B2	USPAT	20030218	Customer specific packaging line	700/225	Sleep, Nicholas J. et	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
7	<input type="checkbox"/>	US 6182049 B1	USPAT	20010130	Method and apparatus for controlling product routing in a manufacturing line	705/7	Barker, Brian C. et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
8	<input type="checkbox"/>	US 6502294 B2	USPAT	20030107	Transfer line workpiece inspection apparatus and method	29/430	Kusmierczyk, Richard A. et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
9	<input type="checkbox"/>	US 6594611 B2	USPAT	20030715	Method in an integrated circuit (IC) manufacturing process for identifying and redirecting IC's mis-processed during their	702/119	Beffa, Raymond J.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
10	<input type="checkbox"/>	US 6363329 B1	USPAT	20020326	Method in an integrated circuit (IC) manufacturing process for identifying and redirecting IC's mis-processed during their	702/118	Beffa, Raymond J.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
11	<input type="checkbox"/>	US 6208947 B1	USPAT	20010327	Method in an integrated circuit (IC) manufacturing process for identifying and redirecting IC's mis-processed during their	702/118	Beffa, Raymond J.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
12	<input type="checkbox"/>	US 6067507 A	USPAT	20000523	Method in an integrated circuit (IC) manufacturing process for identifying and redirecting IC's mis-processed during their	702/118	Beffa, Raymond J.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
13	<input type="checkbox"/>	US 5399531 A	USPAT	19950321	Single semiconductor wafer transfer method and plural processing station manufacturing system	700/112	Wu, H. J.	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
14	<input type="checkbox"/>	US 6036426 A	USPAT	20000314	Wafer handling method and apparatus	414/331.14	Hillman, Gary	<input type="checkbox"/>	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>
15	<input type="checkbox"/>	US 20040102864 A1	US-PG PUB	20040527	System and method for high speed control and rejection	700/110	Stack, James et al.	<input type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>	<input checked="" type="checkbox"/>
16	<input type="checkbox"/>	US RE37432 E	USPAT	20011106	Automated apparatus and method for preparing contact lenses for inspection and packaging	53/54	Martin, Wallace Anthony et al.	<input type="checkbox"/>	<input checked="" type="checkbox"/>	<input type="checkbox"/>	<input checked="" type="checkbox"/>